



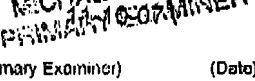


<b>Issue Classification</b> 	<b>Application/Control No.</b> 10/535,134	<b>Applicant(s)/Patent under Reexamination</b> ABRAHAM-FUCHS ET AL.
	<b>Examiner</b> Xiuqin Sun	<b>Art Unit</b> 2863

ISSUE CLASSIFICATION													
ORIGINAL				INTERNATIONAL CLASSIFICATION									
CLASS		SUBCLASS		CLAIMED						NON-CLAIMED			
702		31		G	0	1	N 31	/00					/
CROSS REFERENCES													
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							/					/
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 Xiuqin Sun (Assistant Examiner)	11/13/07 (Date)	 Michael P. Nohien Primary Examiner	34 (Total Claims Allowed)
 (Logan Instruments Examiner)	11/13/07 (Date)	 (Primary Examiner)	1 (O.G. Print Claim(s))
		1 (Date)	1 (O.G. Print Fig.)

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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